

## Notice of References Cited

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Application/Control No.	Applicant(s)/Pate	ent Under	
09/891,806	Reexamination CHANG ET AL.		
Examiner	Art Unit		
David C. Comstock	3732	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,751,935	06-1988	Mast et al.	132/73
	В	US-D380,867	07-1997	Agee, II et al.	D28/56
	С	US-4,615,348	10-1986	Nakata et al.	132/73
	D	US-5,813,415	09-1998	Slali	132/73
	Е	US-4,140,139	02-1979	Aylott	132/73
	F	US-6,189,539	02-2001	Mitchell	132/73
	G	US-D387,488	12-1997	Meyerovich	D28/56
	Н	US-6,196,234	03-2001	Gifford	132/73
	1	US-5,770,184	06-1998	Keller	424/61
	J	US-5,860,429	01-1999	Chang	132/73
	К	US-4,346,720	08-1982	Hokama	132/73
	L	US-5,830,442	11-1998	Beaver	424/61
	М	US-5,873,375	02-1999	Johnson et al.	132/200

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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